Features

- · 3rd generation SiC MOSFET technology
- · Optimized package with separate driver source pin
- · High blocking voltage with low on-resistance
- · High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- · Halogen free, RoHS compliant

Benefts

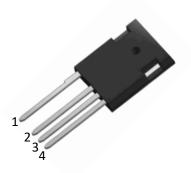
- · Reduce switching losses and minimize gate ringing
- · Higher system effciency
- · Reduce cooling requirements
- · Increase power density
- · Increase system switching frequency

Applications

- · Renewable energy
- · EV battery chargers
- · High voltage DC/DC converters
- · Switch Mode Power Supplies

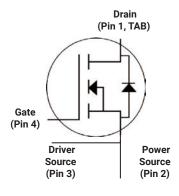
Ordering Part Number	Package	Qty(PCS)	
HIMZA65R030M1HXKSA1	TO-247-4L (TO-247-4)	30	





TO-247-4L (TO-247-4)

Package



Maximum Ratings ($T_C = 25$ °C unless otherwise specifed)

Parameter	Symbol	Value	Unit
Drain-source voltage	Vds	650	V
Continuous drain current Tc = 25°C Tc = 100°C	lo	97 69	А
Pulsed drain current (Tc = 25°C, tp limited by T _{jmax})	D pulse	241	Α
Avalanche energy, single pulse (L=10mH)	Eas	1620	mJ
Gate-Source voltage	Vgs	-5/+20	V
Gate-Source voltage(dynamic,Absolute maximum values)	VGSmax	-10/+25	V
Power dissipation (Tc = 25°C)	Ptot	429	W
Operating junction and storage temperature	Tj , Tstg	-55+175	°C

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
r ai ailielei	Syllibol	min.	typ.	max.	Offic	rest Condition
Static Characteristic						
Drain-source breakdown voltage	BVpss	650	-	-	V	Vgs=0V, Ib=250uA
Gate threshold voltage	VGS(th)	2	-	4	V	Vbs=Vgs,lb=15mA
Zero gate voltage drain current	loss	-	1 10	100	μA	Vps=650V,Vgs=0V T _j =25°C T _j =175°C
Gate-source leakage current	Igss	-		250	nA	Vgs=20V,Vps=0V
		-	30	-		Vgs=18V, ID=33.5A,
Drain-source on-state resistance	RDS(on)	-	25 34	45 -	m	Vgs=20V, Id=33.5A, Tj=25°C Tj=175°C
Transconductance	g fs	-	5.6	-	S	Vps=20V,lp=17.6A
Dynamic Characteristic				L		
Input Capacitance	Ciss	-	3280	-		V _{DS} = 650V V _{GS} = 0V T _J = 25°C V _{AC} = 25mV f = 1MHz
Output Capacitance	Coss	-	359	-	pF	
Reverse Transfer Capacitance	Crss	-	33	-		
Gate Total Charge	QG	-	172	-		Vps = 400V Vgs = -5/20V Ip = 33.5A
Gate-Source charge	Qgs	-	41	-	nC	
Gate-Drain charge	Qgd	-	38	-		
Turn-On Switching Energy	Еом	-	478	-	μJ	V _{DD} = 400V V _{GS} = -5/+20V I _D = 33.5A R _G = 10 L = 100uH
Turn-Off Switching Energy-	Eoff	-	115			
Turn-on delay time	t _{d(on)}	-	32	-	ne	
Rise time	tr	-	44	-		
Turn-off delay time	td(off)	-	84	-	ns	
Fall time	tf	-	22	-		
Gate resistance	Rg	-	1.1	-		Vac = 25mV, f=1MHz

SiC Power MOSFET N-Channel Enhancement Mode

Body Diode Characteristic

Parameter	Symbol	Value		Value Uni	Value Unit Tes	Test Condition
l arameter	Syllibol	min.	typ.	max.	Offic	rest Condition
Body Diode Forward Voltage	Vsp		3.2		V	Vgs=0V,Isd=8.8A, Tj=25°C
Body Diode Polward Voltage	V 3D		2.6			Vgs=0V,Isp=8.8A, TJ=175°C
Continuous Diode Forward Current	ls		83		А	Vgs= 4V,Tc =25°C
Body Diode Reverse Recovery Time	trr	-	40	-	ns	Vr = 400V, Ip = 17.6A
Body Diode Reverse Recovery Charge	Qrr	-	156	-	nC	di/dt = 1000A/μS

Typical Performance Characteristics

Fig 1. Output Characteristic (T_J=-55°C)

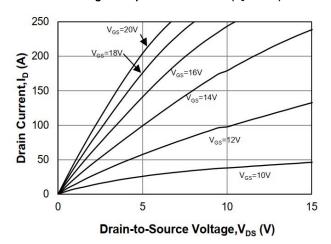


Fig 2. Output Characteristic (T_J=25℃)

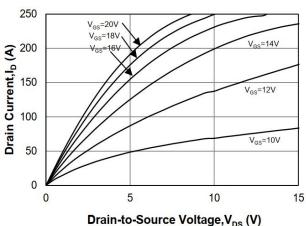


Fig 3. Output Characteristic (T_J=175℃)

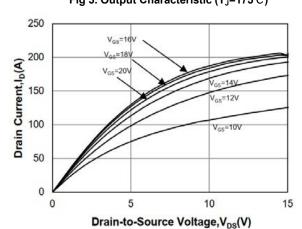


Fig 4: Rdson Vs Ids Characteristic

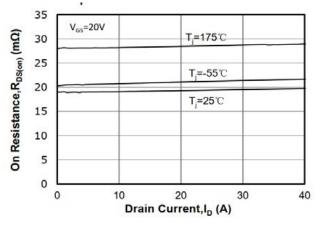


Fig 5: Rds(on) vs. Temperature

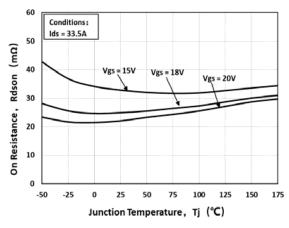
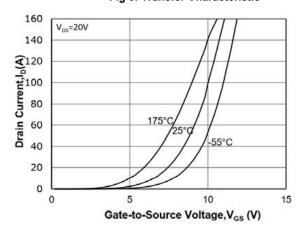


Fig 6: Transfer Characteristic



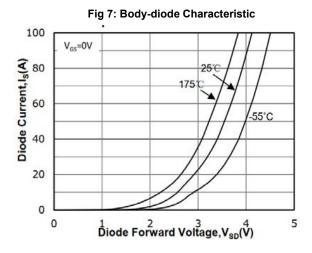
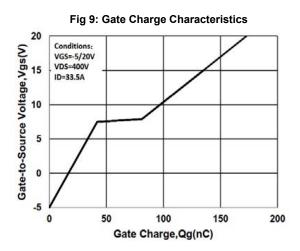
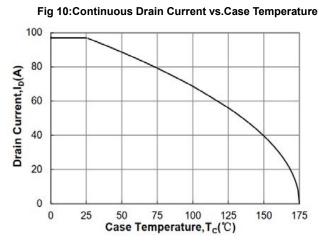
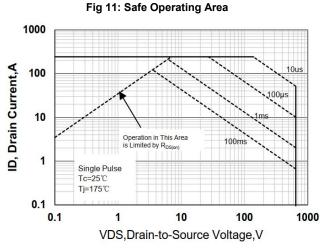
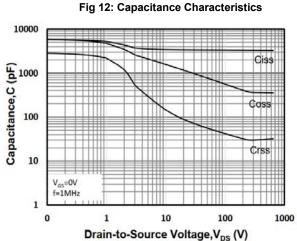


Fig 8: V_{TH} Vs T_J Temperature Characteristic 2 1.8 ID=15mA 1.6 V_{th}(V)_Normalized 0.4 0.2 0 -50 -25 0 50 75 100 125 150 25 Junction Temperature,Tj(℃)









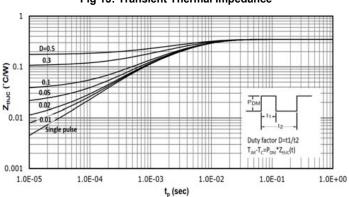


Fig 13: Transient Thermal Impedance

Test Circuit & Waveform

Figure A. Definition of switching times

V_{DS} 90%

V_{GS} 10%

t_{d(on)} t_r t_{off} t_{off}

Figure B. Dynamic test circuit

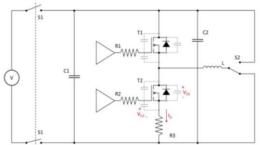
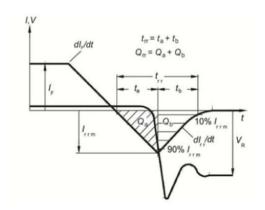
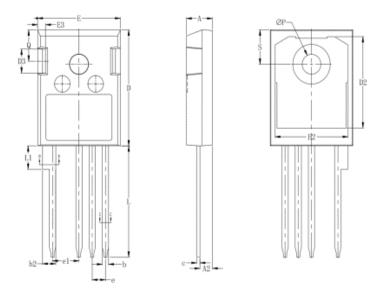


Figure C. Definition of body diodeswitching characteristics



Package Dimensions

Package TO-247-4L(TO-247-4)



Items	Values(mm)				
Items	MIN	MAX			
Α	4.8	5.2			
A2	2.2	2.6			
b	1.05	1.4			
b2	2.4	2.75			
С	0.5	0.75			
D	20	21.5			
D2	15.5	17.2			
D3	4	5			
E	15.5	16.1			
E2	13	15			
E3	1	2			
e	2.54 BSC.				
e1	5.08 BSC.				
L	19	21			
L1	4	4.45			
ФР	3.5	3.7			
Q	5.4	5.9			
S	5.9	6.4			

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